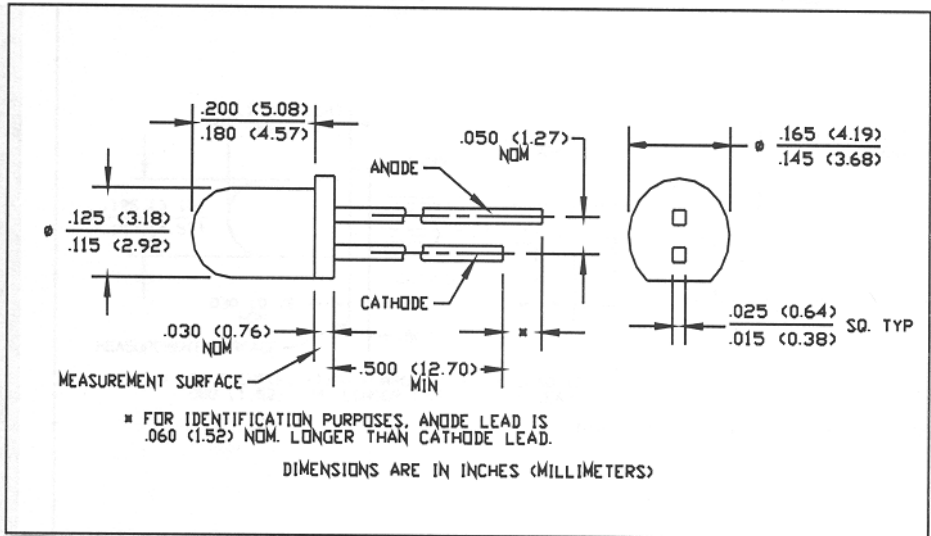
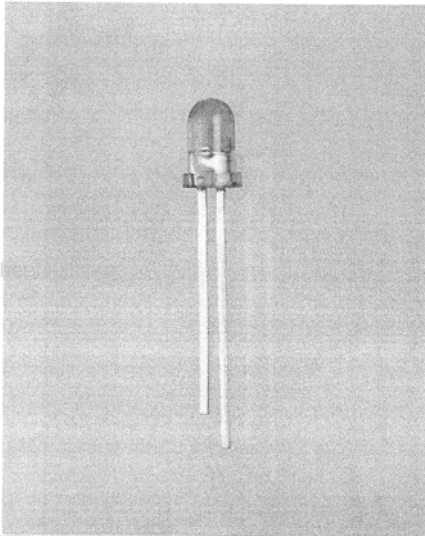


# GaAs Plastic Infrared Emitting Diodes Types OP165A, OP165B, OP165C, OP165D



### Features

- Narrow irradiance pattern
- Mechanically and spectrally matched to the OP505 and OP535 series devices
- Variety of power ranges
- Small package size for space limited applications
- T-1 package style

### Description

The OP165 series devices are 935 nm gallium arsenide infrared emitting diodes molded in IR transmissive amber tinted plastic packages. The narrow irradiance pattern provides high on-axis intensity for excellent coupling efficiency.

### Replaces

K6500 series  
OP163 Series

### Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

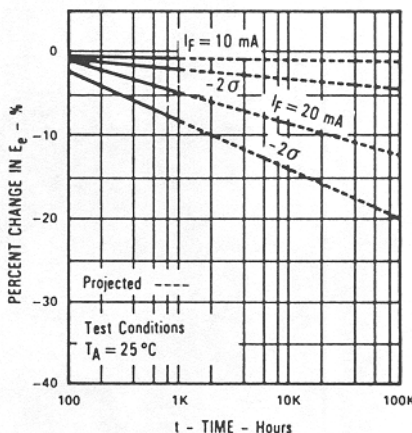
Reverse Voltage	2.0 V
Continuous Forward Current	50 mA
Peak Forward Current (1 $\mu\text{s}$ pulse width, 300 pps)	3.0 A
Storage and Operating Temperature Range	$-40^\circ\text{C}$ to $+100^\circ\text{C}$
Lead Soldering Temperature [1/16 inch (1.6mm) from case for 5 sec. with soldering iron]	$260^\circ\text{C}$ (1)
Power Dissipation	100 mW (2)

#### Notes:

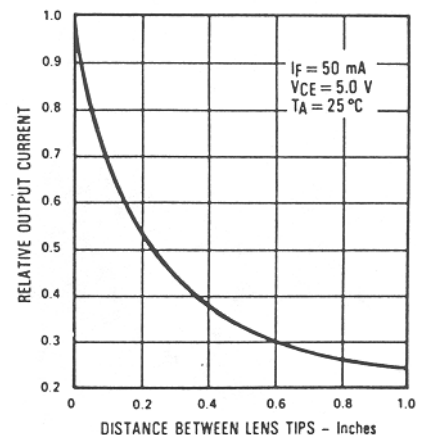
- (1) RMA flux is recommended. Duration can be extended to 10 sec. max. when flow soldering. A max. of 20 grams force may be applied to the leads when soldering.
- (2) Derate linearly 1.33 mW/ $^\circ\text{C}$  above  $25^\circ\text{C}$ .
- (3)  $E_{e(\text{APT})}$  is a measurement of the average apertured radiant incidence upon a sensing area 0.081" (2.06 mm) in diameter, perpendicular to and centered on the mechanical axis of the lens, and 0.590" (14.99 mm) from the measurement surface.  $E_{e(\text{APT})}$  is not necessarily uniform within the measured area.

### Typical Performance Curves

Percent Changes in Radiant Intensity vs Time



Coupling Characteristics  
OP165 and OP505

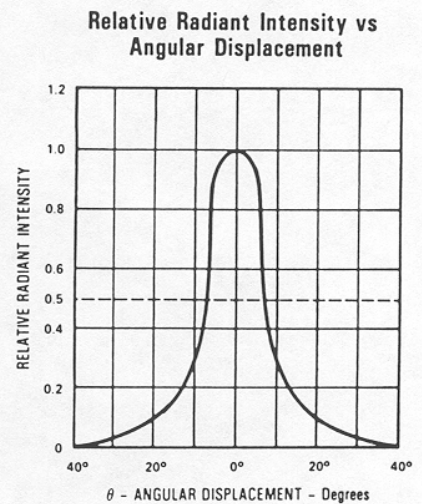
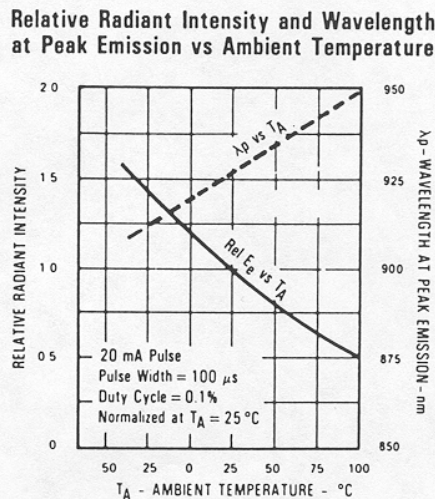
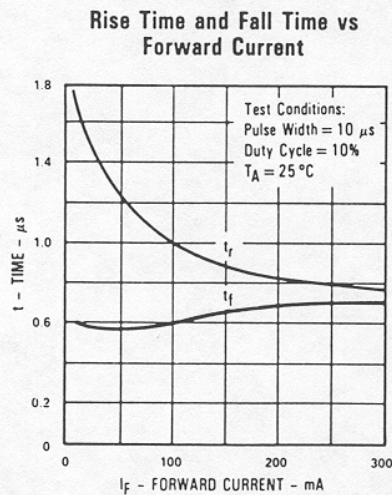
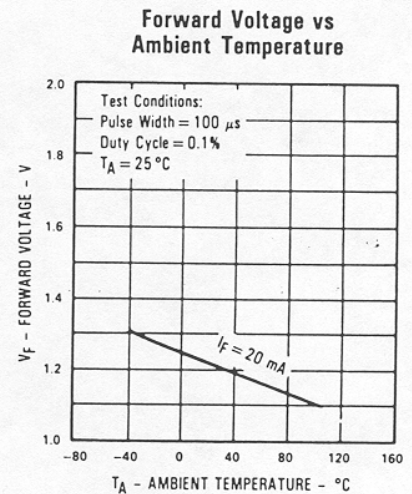
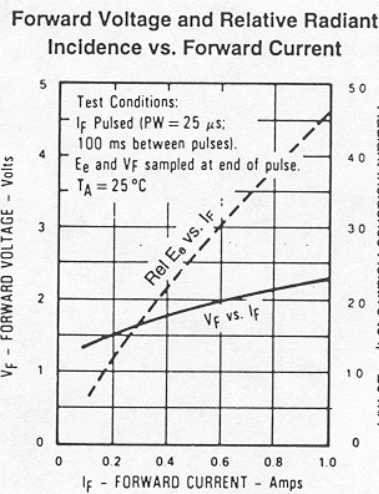
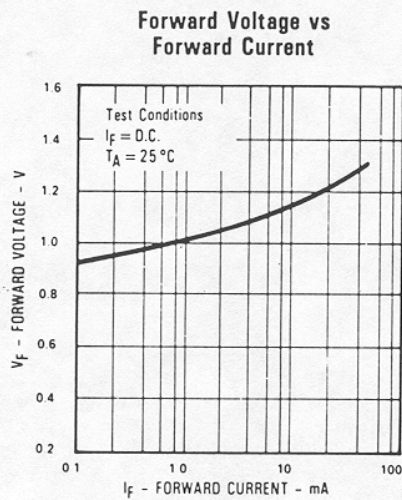


# Types OP165A, OP165B, OP165C, OP165D

Electrical Characteristics ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS	TEST CONDITIONS
$E_e(\text{APT})$	Apertured Radiant Incidence	OP165D	0.28			$\text{mW/cm}^2$ $I_F = 20\text{ mA}^{(3)}$
		OP165C	0.85		1.60	$\text{mW/cm}^2$ $I_F = 20\text{ mA}^{(3)}$
		OP165B	1.40		2.20	$\text{mW/cm}^2$ $I_F = 20\text{ mA}^{(3)}$
		OP165A	1.95			$\text{mW/cm}^2$ $I_F = 20\text{ mA}^{(3)}$
$V_F$	Forward Voltage			1.60	V	$I_F = 20\text{ mA}$
$I_R$	Reverse Current			100	$\mu\text{A}$	$V_R = 2.0\text{ V}$
$\lambda_p$	Wavelength at Peak Emission		935		nm	$I_F = 10\text{ mA}$
B	Spectral Bandwidth Between Half Power Points		50		nm	$I_F = 10\text{ mA}$
$\Delta\lambda_p/\Delta T$	Spectral Shift with Temperature		+0.30		$\text{nm}/^\circ\text{C}$	$I_F = \text{Constant}$
$\theta_{HP}$	Emission Angle at Half Power Points		18		Deg.	$I_F = 20\text{ mA}$
$t_r$	Output Rise Time		1000		ns	$I_{F(\text{PK})} = 100\text{ mA}$ , PW = 10 $\mu\text{s}$ , D.C. = 10%
$t_f$	Output Fall Time		500		ns	

## Typical Performance Curves



Optek reserves the right to make changes at any time in order to improve design and to supply the best product possible.

Optek Technology, Inc. 1215 W. Crosby Road Carrollton, Texas 75006 (972)323-2200

Fax (972)323-2396  
www.DataSheet4U.com